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(54) Title: LEAD-FREE THICK FILM PASTE COMPOSITION

(57) Abstract

A screen-printable thick film paste composition suitable for forming conductive patterns on a rigid substrate comprising: (a) finely divided particles of a lead-free glass composition having a softening point log (eta) = 7.6 poise from 400C-650C, a log (eta) specific viscosity in a range from 2 at 500C to 5 at 700C and consisting essentially of, by weight 65-95 % Bi₂O₃, 2-15 % SiO₂, 0.1-9 % B₂O₃, 0-5 % Al₂O₃, 0-5 % CaO, and 0-20 % ZnO; and (b) electrically conductive particles; and all of (a) and (b) being dispersed in (c) an organic medium.

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TITLE

5 LEAD-FREE THICK FILM PASTE COMPOSITION

Field of the Invention

10 The invention is directed to thick film paste compositions for heated window applications such as automotive backlight defoggers and particularly to such compositions which use a lead-free glass frit as a binder.

Background of the Invention

15 Conventional approaches to compounding frits which are simultaneously low-melting, moderate in expansion and durability and that provide desirable wetting characteristics have included use of lead borosilicate systems (such as those disclosed in U.S. Pat. Nos. 3,258,350, 2,642,633 and 3,404,027) or of lead zinc borosilicate systems (such as those disclosed in U.S. Pat. Nos. 3,873,330 and 3,258,350). However, these lead borosilicate systems have highly toxic lead oxide as their major constituent. This toxic lead oxide must be carefully handled during processing to avoid ingestion or inhalation. Increasing durability of these lead-based systems to prevent acid leaching of the lead component by addition of silica, for example, results in an increased softening temperature.

30 Nontoxic, lead-free frit systems which are low melting, moderate in expansion and durability that provide excellent wetting are not, however, known in the art. Some alkali borosilicate glasses are adequately low-melting and exhibit good wetting, but they are not durable, and they exhibit very high expansion. Other alkali borosilicates such as those sold

- under the trademarks Pyrex (Corning Glass Works) and Kimax (Owens-Illinois, Inc.) are durable, low expansion glasses, but they exhibit high melting properties. Blending or use of an admixture of such borosilicates does not, however, yield a frit
- 5 having the desired low-melting, moderate expansion and moderate durability characteristics. Zinc borosilicates such as those disclosed in U. S. Patent 3,113,878 may provide moderate durability and moderate expansion characteristics; however, such systems do not produce satisfactory low-melting frits.
- 10 Alkali phosphate glasses or arsenic-selenium-tellurium-antimony glasses provide adequate low-melting properties, but they exhibit such poor durability that they are soluble in water at moderate temperatures. While the durability of alkali fluorophosphate glasses is significantly improved, these low melting glasses have poor wetting characteristics.
- 15

Chemically-resistant, lead-free glass frits based on $\text{SiO}_2\text{-Bi}_2\text{O}_3\text{-B}_2\text{O}_3$ chemistry have been disclosed by Francel in U.S. 4,554,258 and by Reinherz in U.S. 4,892,847 for decorative enamels and glazes. Francel teaches $\text{SiO}_2\text{-Bi}_2\text{O}_3\text{-B}_2\text{O}_3$ compositions containing by weight 29 to 38% SiO_2 , 48 to 57% Bi_2O_3 , 3 to 8% B_2O_3 , about 2 to 8% alkali metal oxide and up to 9% alkaline earth oxide. Reinherz further teaches $\text{SiO}_2\text{-Bi}_2\text{O}_3\text{-B}_2\text{O}_3$ frits containing by weight 25 to 35% SiO_2 , 25 to 45% Bi_2O_3 , and 10 to 25% B_2O_3 modified by the addition of 4 to 19% alkali metal oxide and 0.3 to 8% of $\text{ZrO}_2 + \text{TiO}_2$. These glass compositions differ from binders used in the present invention in that the prior art compositions contain significantly higher levels of silica and lower levels of bismuth oxide, thus do not provide the proper combination of excellent wetting and flow required for highly filled conductor compositions.

Dumesnil et al. in U.S. 2,942,992 teach the use of 5 to 50% alkali metal bismuth-borosilicate frit in combination with 95% to 50% bismuth trioxide as the binder for silver particles to

form solderable silver compositions having good adhesion to high TiO_2 dielectric capacitor bodies. These glass frits consist essentially of 2 to 10% alkali metal oxide, 9 to 32% SiO_2 , 35 to 75% Bi_2O_3 , 5 to 15% B_2O_3 , and 0 to 35% cadmium oxide by weight. Dumesnil stresses that the alkali metal oxide is essential to the frit in order to obtain a commercially workable binder system. The bismuth borosilicate frits disclosed in the prior art require the use of alkali metal oxide as a modifier, while the desired performance criteria of solderable conductors in the present invention are obtained through the excellent wetting properties of preferred bismuth borosilicate frit compositions modified with CaO , ZnO , and Al_2O_3 .

Consistent with efforts to reduce or eliminate lead and cadmium from broad categories of products containing glass frits, the present invention deals with a lead-free glass frit that has been shown to be useful in the formulation of electrically conductive materials for heated window applications including automotive backlight rear window defoggers. In addition to providing an alternative chemistry to the lead-based frits of the prior art, the frit component of a heated window conductor composition must exhibit several important properties such as:

- 1) providing the appropriate viscosity and wetting of the substrate when fired to form a bond between the conductor and the glass substrate;
- 2) providing the appropriate viscosity and wetting of the metal powder during firing to enable sintering of the powder to form a dense conductor which exhibits excellent solder wettability;
- 3) minimizing the residual stress state between the conductor composition and the glass substrate, thus lowering sensitivity of the composite structure to temperature cycling.

The heated window conductor composition of the present invention achieves all of the above-stated advantages

without the use of a lead-based frit binder. Preferred compositions of the lead-free frit component have been identified which, in addition, impart improved chemical durability in aqueous acetic acid. Furthermore, the excellent 5 wetting characteristics of the lead-free frit component make it ideal for blending with durable frits of alternative lead-free chemistries including those with inferior wetting behavior to yield conductor compositions which exhibit outstanding performance properties and broad process latitude. Conductor 10 compositions using these frit blends can be processed over a wide range of firing temperatures throughout which acceptable adhesion is consistently obtained and enhanced durability to acetic acid is exhibited.

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Summary of Invention

In its primary aspect, the invention is directed to a screen printable thick film paste composition suitable for 20 forming conductive patterns on a rigid substrate comprising:

- (a) finely divided particles of a lead-free glass composition having a softening point $\log(\eta_a) = 7.6$ from 400C-650C, a $\log(\eta_a)$ specific viscosity in a range from 2 at 500C to 5 at 700C 25 and consisting essentially of, by weight 65-95% Bi_2O_3 , 2-15% SiO_2 , 0.1-9% B_2O_3 , 0-5% Al_2O_3 , 0-5% CaO , and 0-20% ZnO ; and
- (b) electrically conductive particles; and
- 30 all of (a) and (b) being dispersed in (c) an organic medium.

In a secondary aspect, the invention is directed to the utilization of solderable conductive paste containing lead-free glass compositions on a rigid substrate such as automobile 35 backlights, i.e., rear defogger windows.

In a still further aspect, the invention is directed to a lead-free glass composition.

Detailed Description of the Invention

- 5 Manufacturers utilize conductive defogger formulations to form a circuit grid permanently attached to a rigid substrate which is capable of producing heat when powered by a voltage source. Specific physical and chemical
10 functional properties required of conductor materials for use in heated window circuitry include electrical conductivity, good solderability, adhesion to glass and to decorative enamel, chemical durability and reliability under varying environmental conditions including temperature and humidity. Applications in
15 the area of automotive backlight defoggers further require eye appealing cosmetic appearance characteristics which are important to the consumer. In general, conductor compositions suited for heated window applications include finely divided particles of an inorganic binder and a conductive metal powder dispersed in an organic medium.
20

A Inorganic Binder

- 25 A key constituent in the formulation is finely divided particles of an inorganic glass frit. The frit is required for bonding sintered metal powders, thus the softening point and viscosity of the frit during firing, as well as its wetting characteristics for the metal powder and the substrate are critical. The particle size of the frit is not narrowly critical and
30 frits useful in the present invention will typically have an average particle size from about 0.5 to 4.5 microns, preferably from about 1 to about 3 microns. The amount of binder will typically be from about 1 to 20% by weight of the conductor composition (excluding the organic medium), preferably about 1 to 10% by weight, and more preferably about 1 to 6% by weight. Wetting of
35

a solid surface by a liquid is defined in a general sense in terms of a contact angle formed between liquid-solid interface and a tangent to the surface of the liquid at the contact point. The smaller the contact angle, the better the wetting that is exhibited and the less glass that is required to completely wet a given surface area of solid. A preferred firing temperature between 580 to 680C is desired for a frit or frit mixture formulated as a thick film conductor for heated window applications. The glass viscosity expressed as log (eta) should be less than 4 at 680C for a single frit or a volumetrically computing average log (eta) for a frit mixture. The units of glass viscosity used herein are poise. The linear weighted average viscosity can be approximated by computing the summation of the respective products of the log (eta) specific viscosity for the individual frit component referenced to log (eta) at a specified temperature (such as 680C) and its volume fraction of total frit in the formulation.

Minimization of stress between a thick-film conductor and a substrate is dependent upon their thermal expansion properties, respective moduli of elasticity and relative thickness. Automotive glass has a thermal coefficient of expansion (TCE) of about $9 \times 10^{-6}/\text{C}$. Silver metal, the higher primary constituent of the conductor composition, has a higher TCE ($17.5 \times 10^{-6}/\text{C}$) but also has a substantially lower modulus compared to glass. To take advantage of the lower modulus of elasticity of metal compared to glass, it is desirable to use the lowest practical amount of glass binder in the conductor formulation, thereby minimizing the stress at the bonding interface. A glass binder which exhibits excellent wetting properties allows the formulator to minimize the amount of binder needed while maintaining excellent solderability and adhesion.

Prior art conductors for heated automotive windows have been based on lead frits. Eliminating lead from glass compositions to meet current toxicity and environmental concerns limits the options with suitable low softening and flow properties while also meeting wettability, thermal expansion, cosmetic and performance requirements. The current invention deals with the unexpected outstanding performance of a series of glasses based upon the constituents: Bi_2O_3 , Al_2O_3 , SiO_2 , CaO , ZnO , and B_2O_3 , all of which meet requirements for low toxicity.

B. Electrically Functional Materials

Metal particles such as gold, silver, platinum, palladium, or mixtures and alloys thereof, can be used in the practice of this invention. The particle size of the metal powder or flake is not by itself narrowly critical from the standpoint of technical effectiveness. However, particle size does affect the sintering characteristics of the metal in that large particles sinter at a lower rate than small particles. Blends of powders and/or flakes of differing size can be used to tailor the sintering characteristics of the conductor formulation during firing, as is well known in the art. The metal particles must, however, be of a size appropriate to the method of application, which is usually screen printing. The metal particles should therefore be no larger than 20 microns in size and preferably no larger than 10 microns. The minimum particle size is normally about 0.1 micron.

The preferred metal for conductor compositions suitable for automotive backlight defoggers is silver. Silver particles larger than 1.0 micron impart greater coloring power to the paste. Therefore, it is preferred that the compositions of the invention contain at least 50% wt. silver particles larger than 1.0 micron. The silver will ordinarily be of high purity (99+%).

However, less pure materials can be used with due consideration for the electrical requirements of the pattern. The amount of silver in the composition will usually be 50-90% wt. on a paste basis (e.g., including the liquid organic medium), and 60-99% wt after firing.

C. Organic Medium

10 Finely divided particles of electrically functional material and inorganic binder will ordinarily be dispersed in an organic medium to form a semi-fluid paste which is capable of being printed in a desired circuit pattern. The organic medium can be any suitably inert liquid, nonaqueous inert liquids being preferred, which provides appropriate wettability of the solids and the substrate, a relatively stable dispersion of particles in the paste, good printing performance with acceptable screenlife, dried film strength sufficient to withstand rough handling, and good firing properties. Any one of various organic liquids with or without thickening agents, stabilizing agents and/or other common additives can be used. Exemplary of the organic liquids which can be used are alcohols, esters of such alcohols such as the acetates and propionates; terpenes such as pine oil, terpineol and the like; and solutions of resins such as polymethacrylates, polyvinylpyrrolidone or ethyl cellulose in solvents such as pine oil and mono-butyl ether of diethylene glycol monoacetate. The medium can also contain volatile liquids to promote fast setting after printing to the substrate. The organic medium will ordinarily constitute 5-50% wt. of the paste.

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A preferred organic medium used herein is based on a combination of a thickener consisting of ethyl cellulose in terpineol (ratio 1 to 9), combined with the monobutyl ether of ethylene glycol monoacetate sold under the tradename butyl Carbitol acetate. The conductive paste compositions are

conveniently prepared on a three-roll mill. A preferred viscosity for these compositions is approximately 30-100 Pa.S measured on a Brookfield HBT viscometer using a #5 spindle at 10 rpm and 25C. The amount of thickener utilized is determined by the final desired formulation viscosity, which, in turn, is determined by the printing requirements of the system.

A sintering inhibitor which facilitates formation of a preferred conductor microstructure during sintering can 10 optionally be employed in the present invention and when present is typically incorporated into the paste prior to rollmilling. Up to 1% of sintering inhibitor may be added to retard the rate of metal densification during the firing cycle so long as the performance properties of the conductor 15 composition are not degraded. Finely dispersed refractory oxides on the surface of the metal particles serve to inhibit sintering and can be obtained by either dispersing the oxide additive in the organic medium or, preferably, by adding a metal resinate which decomposes during firing to form a finely dispersed refractory oxide in situ. Preferred sintering 20 inhibitors for the conductive metal are oxides of rhodium (Rh) and ruthenium (Ru) and those rhodium- and ruthenium-based compounds which, under the firing conditions to which they are subjected, are changed to the oxides of the metals. Such 25 materials can be in either particulate form or in the form of organometallic compounds which are soluble in the organic medium. For example, suitable Ru-based materials include Ru metal, RuO₂, Ru-based pyrochlore compounds such as bismuth lead ruthenate, and copper bismuth ruthenate, Ru resinates and 30 mixtures thereof. Suitable Rh-containing materials include Rh metal, RhO₂, Rh₂O₃, Rh resinates and mixtures thereof. Especially preferred sintering additive materials for use in the invention are RuO₂, copper bismuth ruthenate and Rh resinate. Nevertheless, it should be recognized that the inhibitors can also 35 be present in the form of a coating on the conductive metal

particles. Such coatings can be produced by dispersing the conductive metal particles in a solution of a resinate of the metal of the sintering inhibitor, removing the bulk of the liquid from the dispersion and then drying the particles to form an oxide

5. coating. Alternatively, a thin layer of refractory metal oxide can be coated onto the finely-divided metal powder as described in U.S. 5,126,915 to inhibit premature sintering of the metal powder prior to dissolution of the refractory oxide by the glass frit component. Additional optional ingredients well known to 10 those skilled in the art include surfactants, thickeners and flow agents to adjust paste rheology; up to 5 wt. % pigment to enhance color without degrading resistivity, solderability or adhesion; colorants including those taught by Eustice in U.S. 4,446,059; and frits and/or metal oxides which during firing 15 oxidize silver to silver oxide that diffuses in the adjacent window glass and subsequently precipitates as an attractive stain visible through the glass.

20 Test Procedures

1. Thermal Expansion/ Dilatometric Deformation Point

Rectangular sample bars are prepared by bi-
25 directionally pressing glass frit in a tool steel die. The pressed samples are then fired at a temperature sufficient to completely densify the bar. The cooled sample is placed into an Anter Model 1121 dilatometer (Anter Laboratories, Inc., Pittsburgh, PA) and the thermal expansion behavior is measured as a
30 function of temperature up to the temperature of sample deformation, i.e., the temperature where the sample expansion peaks and contraction begins (due to glass flow). This dilatometric deformation temperature approximately corresponds to a glass viscosity of $\log (\eta) = 13$ to 14.

2. Glass Viscosity

5 The method of viscosity determination for individual frit components may be performed by the use of the parallel plate method on bulk glass samples. The measurements are commercially available from Corning CELS Laboratory Services (Corning, NY).

10 The viscosity measurements in this case involve the use of the parallel plate method which was originally proposed by G. J. Dienes and H. F. Klemm (J. Appl. Phys., 17 (6), p. 458, 1946). In this method, a pellet-shaped glass sample is put under stress between two parallel and contacting plates. The glass sample completely fills the space between the ceramic 15 platens at all times. The rate at which the platens approach one another is measured during the slow heating and loading of the sample. The viscosity is calculated using the following equation:

$$\text{eta} = -(2 h^3 M g) / (3 \pi a^4 (dh/dt))$$

20 where

eta = viscosity (poise)

h = distance between platens (meters)

M = mass (kilograms)

25 g = gravitational acceleration (9.80 meters/sec²)

a = radius of platens (meters)

t - time (seconds)

30 Samples typically used are made 6 mm in diameter and 1 mm thick. Ceramic rods 6.35 mm in diameter, 4-7 mm in length with flat ground faces on the ends are used as contact platens for the glass samples. An external metal jig is used to support the rods without restricting vertical movement. Samples are inserted between the platens in a furnace while

temperature and weight loading may be changed to measure the effect on deformation rate.

The valid measurement range of this technique is log (eta) from 5 to 10, however, data derived from this measurement may be exponential curve fit to extrapolate to somewhat higher or lower values. Measurements can be verified by the Beam Bending Method described by H. E. Hagy (J. Am. Cer. Soc., 46 (2), p. 93, 1963) with agreement within 5-10C for the annealing and strain point, i.e., log (eta) = 13.5 and 14.5 respectively. The rotating cylinder method may be used to confirm viscosity extrapolations for values of log (eta) = 3 or lower. Fiber softening temperatures obtained by the ASTM fiber elongation method C338-57 correspond to log (eta) of 7.6.

15

3. Particle Size, Surface Area and Tap Density

Particle size is measured using a Microtrac® Model 7998 Particle Size Analyser with Advanced Computer Control made by Leeds and Northrup (St. Petersburg, FL). The surface area is measured using the BET method on a Micrometrics Flowsorb II-2300 Gas Adsorption apparatus. Samples were degassed (using the Desorb 2300A unit) by heating them to an elevated temperature in a stream of dry N₂ for a specific period of time suitable for the material tested prior to the gas adsorption measurement. Apparent volume of a powder is measured in a graduated cylinder after tapping to consolidate the powder. Tap density (TD) is calculated by dividing a powder's apparent volume by its corresponding weight.

20

4. Resistance

The resistance of fired silver conductor traces is measured using a Hewlett Packard 3478A Multimeter. Conductor thickness is measured using a Dektak 3030 surface profilometer. Sheet resistance is calculated in ohms per square

by dividing resistance by the number of squares in the printed pattern. This number is 486 mm/0.76 mm = 640 squares.

5. Adhesion

- 5 Copper clips are soldered by reflowing a 70/27/3 Pb/Sn/Ag solder alloy over the fired silver conductor on 3/16-inch thick glass substrates. Adhesion of the clip to the silver is measured using an Instron Model A2-140 tensile tester.
10 Adhesion values greater than 40 pounds are preferred. Aged adhesion is measured after exposure of the soldered test structure to an 85C/ 85% RH environment for a week.

6. Acid Resistance of Conductor Pastes fired on Substrate

- 15 The fired conductor sample is placed in a jar containing about 500 ml of a 4% acetic acid solution such that half of the circuit pattern is submerged in the solution and half remains in the air above the solution. After 1 minute exposure, the sample is removed, rinsed in a stream of deionized water and dried with a paper towel. The sample is visually observed
20 under a high intensity light source which simulates daylight noting any difference in the stained color of silver (by viewing the circuit pattern through the glass substrate) between sample area which had been immersed in acid vs. the area of the sample which had not been immersed. A rating is assigned according to
25 the scale:

5 = no difference (acid resistant)

3 = mild difference

1 = major difference (high contrast)

- 30 The sample is again placed in the acid solution with the same half of the circuit pattern immersed in the acid solution for an additional four minutes. The sample is then removed, rinsed in deionized water, dried and tested for acid resistance by scratching the surface using a razor knife. A scratch is begun in the sample area which had not been immersed and continued
35 into the area which had been immersed in acetic acid solution.

The acid resistance is rated based on the visual difference in the scratch between the two areas according to the scale:

- Rating 5 = no difference (acid resistant)
5 3 = mild difference (scratch widened)
 1 = major difference (material easily removed)

Example 1

10 A series of glass compositions were prepared and tested to illustrate the present invention, as shown in Table 1. Raw materials used to prepare the glass batches were bismuth oxide, Bi_2O_3 ; aluminum oxide, Al_2O_3 ; zinc oxide, ZnO ; vitreous silica, SiO_2 ; and boric anhydride, B_2O_3 . The batch materials
15 were weighed and combined with mixing prior to insertion into the platinum alloy crucible. The crucible containing the batch mixture was inserted into a furnace controlling at 1100C. Approximately 30 minutes of melting preceded the quenching of the glass. The glass was quenched between contra-rotating
20 metal rollers with a narrow gap (10-25 mil). The glass frit flake was then milled in water in a ball mill to a mean particle size of about three micrometers. After discharging the milled frit slurry from the mill through a U.S. Standard 100 mesh screen, the frit powder was oven-dried at 150C. Further Sweco milling
25 of Sample D and E was performed to attain frits having a mean particle size of about one micrometer. The milled glass powders were tested for stability (freedom from phase separation, or crystallization). Measurement of thermal expansion properties was performed for each glass.

Table I

	A	B	C	D	E
Bi ₂ O ₃	75.1 wt%	75.1 wt%	73.0 wt%	72.46 wt%	69.81 wt%
Al ₂ O ₃	0.9 wt%	1.8 wt%	2.0 wt%	2.02 wt%	2.13 wt%
CaO	2.5 wt%	1.0 wt%	0.5 wt%	0.5 wt%	0.53 wt%
ZnO	10.0 wt%	10.0 wt%	10.0 wt%	10.32 wt%	12.03 wt%
SiO ₂	10.0 wt%	10.0 wt%	7.0 wt%	6.75 wt%	7.11 wt%
B ₂ O ₃	1.5 wt%	2.1 wt%	7.5 wt%	7.95 wt%	8.38 wt%
Dilatometric Deformation Point	478 °C	471 °C	450 °C	453 °C	452 °C
TCE @ dil. DP (1/C) × 10 ⁶	10.04	10.48	11.7	10.5	8.4
TCE @ RT-400 °C (1/C) × 10 ⁶	9.55	9.16	9.05	9.00	8.60

5 A commercially available lead-free alkali
fluorophosphate glass frit Pemco 2J57 (Miles Co. Baltimore, MD)
was obtained having a dilatometric deformation point of about
380C and a thermal coefficient of expansion (TCE) between
room temperature and its deformation point of 21 ppm/C. This
10 frit was milled using a fluidized bed jet mill in which the glass
particles are impinged upon each other to obtain size reduction
and then collected in a cyclone. The resultant jet-milled frit
(designated CF#1) had an average particle size of about 3
microns.

15 Example 2

Glass durability was determined by measuring the
weight loss of fully dense glass beads upon exposure to an
aqueous 4% acetic acid for 15 minutes (Table 2). The glass
beads were prepared by sintering about 0.2 to 0.4 gms of frit at a
20 temperature that allowed for complete densification. The
durability of the lead-based frits improved with decreasing lead
content. LF #1 is a lead cadmium borosilicate frit, LF #2 is a
lead bismuth borosilicate frit, and LF #3 is a lead zinc

borosilicate. The durability of the glasses of the present invention was unexpected in light of their low silica content.

5

TABLE 2

Glass	C	D	E	LF#1	LF#2	LF#3	CF#1
% weight loss	0.42	0.35	0.13	22.88	8.88	0.33	0.00

10 Example 3

Glass viscosity data were obtained for Glass E and CF #1 as presented in Table 3. Using these viscosity data, the temperatures corresponding to log (eta) viscosity of 10, 7.6, 6 and 4 were determined (Table 4.). Based on these data, a glass binder having a softening point [log (eta) = 7.6] below 525C and a specific viscosity of log (eta) of less than 5 is required to obtain suitable glass flow to enable conductor densification at the firing temperature 610 to 660C. For conductors having a thermal processing window between 580 to 680C, the critical viscosity limits are between log (eta) = 2 and 4 at a processing temperature of 610C.

25 Ident.

TABLE 3

	Log (Viscosity) @ Temp.				
	400C	500C	600C	650C	700C
Glass E		8.7	4.0	2.9	2.2
CF#1	12.7	3.9	1.6	1.1	0.8

30

TABLE 4

Ident.	Temperature (deg C) @ Viscosity			
	10	7.6	6	4
Glass E	484	516	545	601
CF#1	418	440	460	498

10

Glass frits were then formulated in silver conductor compositions suitable for heated window defogger applications. The conductor formulations including the glass frit, the silver powders, and sintering inhibitor (if present) were mixed into an organic medium of ethyl cellulose in terpineol to wet out the powders and then dispersed by rollmilling. Pastes were adjusted to a suitable printing viscosity, if required. Characteristics of the silver powders used in conductor compositions presented in the following examples are listed in Table 5.

TABLE 5
SILVER POWDER CHARACTERISTICS

Sample	Morphology	SA (m ² /g)	TD (g/cc)
S1	irregular	0.2 to 0.4	1.5 to 3.0
S2	irregular	1.8 to 2.2	1.8 to 2.1
S3	flake	0.6 to 0.9	4.0 to 6.0
S4	spherical	0.5 to 0.7	4.0 to 5.0

30

The following procedure was used to prepare small scale conductor test circuits for evaluation in the following examples:

1. Decorative enamel paste of either the solvent-based or UV-curable type is screen printed onto a flat glass substrate using a conventional screen, typically 156 or 195 mesh polyester.
5
2. The printed enamel pattern is dried at 150C. for 15 minutes or UV cured at 1.2 J/cm² depending on the type of enamel.
- 10 3. The silver paste is screen printed onto either the airside or tinside of a flat glass substrate or onto unfired enamel using a conventional screen, typically 195 mesh polyester. Other meshes such as 156 and 230 mesh can be used with equal success.
- 15 4. The silver is fired or the silver and enamel are cofired in a belt furnace set to reach a peak glass surface temperature of 580 to 680C and time above 500C of 5 minutes.
- 20 The utility of a particular conductor composition increases as its processing latitude increases, i.e., the width of its firing window is broadened, the firing window being defined as the varying firing temperatures over which acceptable adhesion
- 25 performance is obtained. Adhesion values greater than 40 lbs are desired over both the glass substrate and the enamel. Some compositions identified are suitable for use in applications requiring acetic acid resistance.
- 30 Examples 4 through 13 illustrate silver conductor formulations based on a single glass frit as presented in TABLES 6, 7 & 8.

Table 6

Example	4		5		6	
	Frit	Ingreds. (%)	Frit	Ingreds. (%)	Frit	Ingreds. (%)
	LF #1	4.0	C	4.0	D	4.0
	Silver I	70.0	Silver I	70.0	Silver I	70.0
Properties						
Peak Firing T (°C)	610	620	630	640	650	660
Adhesion Over Glass (lb)	57.5	54.5	52.0	54.0	47.5	49.0
Adhesion Over Enamel (lb)	67.0	66.3	61.0	43.8	65.5	64.0
Aged Adhesion Over Glass (lb)			57.3		35.5	26.0
Fired Thickness (μm)	12.3	12.4	12.1	11.6	12.2	12.5
Electrical Rs (mΩ/sq)	4.2	4.2	4.1	4.0	4.4	4.3
Electrical Resistivity (μΩ·cm)	5.1	5.2	5.0	4.6	5.4	5.4
Acid Resistance Rating						
5 = Excellent						
1 = Poor						

1 minute in acid

5 minutes in acid

2

2

3

Table 6 (Continued)

Example	7			8		
	Ingrds.	(%)	Ingrds.	(%)	Ingrds.	(%)
Frit E	4.0		Frit D	4.0		
Silver I	70.0		Silver I	84.0		
Properties						
Peak Firing T (°C)	610	620	660	610	620	660
Adhesion Over Glass (lb)	51.8	75.7	88.5	59.5	50.5	52.5
Adhesion Over Enamel (lb)	64.5	68.5	55.3	30.7	86.3	96.0
Aged Adhesion Over Glass (lb)			66.3			93.3
Fired Thickness (μm)	12.9	13.0	12.3	12.3	23.3	23.3
Electrical Rs (m Ω /sq)	4.2	4.1	4.1	4.0	1.7	1.7
Electrical Resistivity ($\mu\Omega\cdot\text{cm}$)	5.3	5.4	5.3	4.9	4.0	3.9
Acid Resistance Rating						3.5
5 = Excellent						
1 = Poor						

1 minute in acid

5 minutes in acid

2

5

Examples 4 through 7 (Table 6) use 4 wt. % of glass frit having an average particle size of 2.5 to 3.0 microns and 70 wt % Silver I, where the silver is a blend of 48% coarse powder (S1) and 22% of submicron powder (S2). Example 4 uses a conventional lead borosilicate frit while examples 5, 6 and 7 use glasses C, D and E, respectively, as illustrated in Table 6.

Example 4 illustrates the wide firing window for a typical conductor composition for heated automotive windows based on a single conventional lead borosilicate frit (LF #1). Examples 5, 6 and 7 based on frits of the present invention which do not contain lead show similar results. Example 7 containing frit E gives comparable or higher adhesion results versus the conventional lead borosilicate frit (Example 4). Note that in each case, the adhesion over enamel is somewhat degraded for the highest firing temperature (660C). Acid resistance for examples 4 to 7 is in the low to average range.

Example 8 (Table 6) illustrates the effect of increased silver content on fired properties compared to Example 6 containing the same frit. Example 8 contains 84% Silver I where the silver is a blend of 66% coarse powder (S1) and 18% submicron powder (S2). In addition to decreased sheet resistance, Example 8 showed similar adhesion over glass except at 660C; higher adhesion over enamel; a wider firing window over enamel; and increased acid resistance.

Table 7

Example	9			10			11			12		
	Ingrds.	(%)	Ingrds.	(%)	Ingrds.	(%)	Ingrds.	(%)	Ingrds.	(%)	Ingrds.	(%)
	Frit E	4.0	Frit E	4.0	Frit E	4.0	Frit E	4.0	Frit E	4.0	Frit E	8.0
	Silver II	74.5	Silver II	74.5	Silver II	74.5	Silver II	74.5	Silver II	74.5	Silver II	74.5
	Rh Res.	0.2	Rh Res.	0.2	Rh Res.	0.2	Rh Res.	0.4	Rh Res.	0.4	Rh Res.	0.2
Properties												
Peak Firing T (°C)	580	560	570	580	640	670	580	640	670	580	640	670
Adhesion Over Glass (lb)	110.0	112.8	141.3	137.3	133.5	134.5	142.0	139.3	157.8	120.8	143.3	138.5
Adhesion Over Enamel (lb)	85.5	10.3	0	42.5	120.3	17.8	40.3	135.8	71.0	44.8	25.0	4.0
Fired Thickness (μm)	11.4	10.0	9.9	14.0	12.7	11.7	15.6	14.2	12.6	16.0	14.1	13.7
Electrical Rs (mΩ/sq)	.8	2.5	2.4	4.0	3.4	3.1	5.1	4.2	3.7	3.2	2.8	2.5
Electrical Resistivity (μΩ·cm)	3.2	2.5	2.4	5.5	4.3	3.6	7.9	6.0	4.7	5.1	3.9	3.4
Acid Resistance Rating	5	Excellent	2	5	1	4.5	1	4.5	1	3.5	5	5
1 = Poor												
1 minute in acid												
5 minutes in acid	1	4	1	3.5	1	3.5	1	3.5	1	1	5	5

Examples 9 through 12 (Table 7) illustrate single frit compositions where the frit component has an average particle size of about 1 micron. The silver used in Examples 9 through 12, Silver II, is a combination of 54.5% flake (S3) and 20% submicron powder (S2) which is more easily sintered than Silver I used in Examples 4 to 8 as shown by comparing resistivity of sample 9 (74.5% Silver II) with that of Example 5 (70% Silver I) and Example 8 (84% Silver I).

Examples 9, 10 and 11 (Table 7) illustrate that the addition of the sintering inhibitor rhodium resinate #8866 available from Engelhard (East Newark, NJ) decreased the density of the fired conductor using lead-free frit composition E as shown by the increase in electrical resistivity for the series: example 9 (no inhibitor), Example 10 (0.2% rhodium resinate) and example 11 (0.4% rhodium resinate). The conductor adhesion over enamel was poor for sample 9 (no inhibitor) fired at 640C and 670C, however adhesion over enamel was significantly improved by addition of the sintering inhibitor, thus widening the firing window of the conductor composition.

Increasing the quantity of frit E to 8.0% in Example 12 increased acid resistance with some loss of adhesion over enamel (compare with 4.0% level in Example 10).

Table 8

Example	13			14 (Pb bearing)			15		
	Ingreds.	(%)	Ingreds.	(%)	Ingreds.	(%)	Ingreds.	(%)	Ingreds.
CF #1	2.5	LF #2	2.0	Frit E	2.5				
Silver II	74.5	LF #3	1.0	CF#1	0.5				
Rh Res.	0.2	CF #1	0.5	Silver II	74.5	Rh Res.	0.2		
Properties									
Peak Firing T (°C)	580	620	580	640	620	580	640	620	640
Adhesion Over Glass (lb)	0.3	55.8	62.5	77.5	>100	>100	99.0	>100	>100
Adhesion Over Enamel (lb)	50.8	98.5	>100	70.5	>100	96.0	87.3	>100	>55.0
Fired Thickness (μm)	16.6	13.1	13.1	13.4	14.3	13.5	13.1	12.1	10.7
Electrical Rs (mΩ/sq)	4.9	4.0	4.2	4.2	2.9	2.6	4.3	3.5	3.5
Electrical Resistivity (μΩ·cm)	8.2	5.3	5.4	5.6	4.2	3.5	5.6	4.2	3.7
Acid Resistance Rating									
5 = Excellent									
1 = Poor									
1 minute in acid		5	5	5	5	3	5		
5 minutes in acid		1	1	2	5	2	5		

Table 8 (Continued)

Example	16			17			18		
	Ingreds.	(%)	Ingreds.	(%)	Ingreds.	(%)	Ingreds.	(%)	Ingreds.
Frit E	2.5	Frit E	2.5	Frit E	2.5	Frit E	2.5	Frit E	8.0
CF #1	1.0	CF #1	1.0	CF #1	1.0	CF #1	1.0	CF #1	1.0
Silver II	75.0	S4	74.0	Silver II	74.5	Silver II	74.5	Silver II	74.5
Rh Res.	0.2	Rh Res.	0.2	Rh Res.	0.2	Rh Res.	0.2	Rh Res.	0.2
Properties									
Peak Firing T (°C)	580	640	670	580	640	670	580	640	670
Adhesion Over Glass (lb)	99.5	99.8	89.8	124.0	158.3	133.5	131.0	109.0	110.0
Adhesion Over Enamel (lb)	84.3	98.5	>100	100.7	113.0	141.5	80.0	63.5	30.3
Fired Thickness (μm)	13.7	11.3	10.1	14	13.7	12.2	16.7	14.8	13.7
Electrical Rs (mΩ/sq)	3.8	3.4	3.3	5.6	4.0	3.7	3.4	2.9	2.7
Electrical Resistivity (μΩ·cm)	5.2	3.9	3.3	8.3	5.5	4.5	5.6	4.2	3.2
Acid Resistance Rating	5 = Excellent								
	1 = Poor								
1 minute in acid	4.5	5	5	5	5	5	5	5	5
5 minutes in acid	3.5	5	2	5	2	5	4.5	5	5

Example 13 (Table 8) uses lead-free alkali fluorophosphate glass frit CF #1 of about 3 microns average particle size obtained by jetmilling commercial Pemco 2J57 (Miles Co., Baltimore, MD). Even though this glass has a low dilatometric deformation point of about 380C (compared to 452C for Frit E), its poor wettability results in unacceptable adhesion of the conductor to glass at the low firing temperature (580C). The fired sample was not fully acid resistant as shown by the rating after 5 minutes exposure time.

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The use of glass frit blends to obtain required performance over a wide processing window are illustrated in Examples 14 to 18 (Table 8). These conductor compositions use Silver II, a blend of flake and submicron silver, or spherical silver (S4) and rhodium resinate as a sintering inhibitor.

Example 14 illustrates a state-of-the art commercial lead-bearing conductor composition for heated automotive windows containing a blend of two lead based frits, a lead-bismuth borosilicate composition designated LF #2 and a lead-zinc borosilicate composition designated LF #3, in addition to CF #1, the alkali fluorophosphate frit. Improvements in both acetic acid resistance and process latitude were obtained by using multiple frits in Example 14 compared to Example 4 containing a single frit.

Examples 15 to 18 (Table 8) illustrate blends of lead-free composition E with 1 micrometer average particle size with CF #1, the jet-milled commercial alkali fluorophosphate frit. Blends of lead-free glasses in Examples 15 to 17 provide enhanced properties compared to the conductor examples containing a single frit (Examples 10, 12 and 13). Example 15, 16 and 18 vary the amounts of the frit compositions. Example 17 illustrates the use of a spherical silver (S4). Example 17 uses a water-cleanable organic vehicle based on polyvinylpyrrolidone

and monobutyl ether of diethyleneglycol monoacetate. Examples 15, 16 and 17 illustrate the wide processing latitude yielding excellent adhesion over both glass and enamel and improved acid resistance. These lead-free compositions exceed
5 performance of the state-of-the-art lead-base conductor (Example 14).

Practical application of lead-free glass frits has been evaluated in thick film conductor pastes and comparable
10 performance to Pb bearing silver paste was observed. Optimal performance of the present invention was obtained by combining two or more frits, selecting appropriate silver powders and using Rh resinate as a component of the paste.

WHAT IS CLAIMED IS:

- 5 1. A screen-printable thick film paste composition suitable for forming conductive patterns on a rigid substrate comprising:
 - 10 (a) finely divided particles of a lead-free glass composition having a softening point log (eta) = 7.6 poise from 400C-650C, a log (eta.) specific viscosity in a range from 2 at 500C to 5 at 700C and consisting essentially of, by weight 65-95% Bi_2O_3 , 2-15% SiO_2 , 0.1-9% B_2O_3 , 0-5% Al_2O_3 , 0-5% CaO , and 0-20% ZnO ;
 - 15 (b) electrically conductive particles; and
- 20 all of (a) and (b) being dispersed in (c) an organic medium.
- 25 2. The paste composition of claim 1 wherein the firing temperature is from 580-680C.
- 30 3. The paste composition of claim 1 further comprising an alkali fluorophosphate glass.
- 35 4. The paste composition of claim 1 wherein log (eta) specific viscosity is in a range from 2 at 500C to 4 at 680C.
- 30 5. The paste composition of claim 1 further comprising a sintering inhibitor selected from the oxides of ruthenium, rhodium and mixtures and precursors thereof.
- 35 6. The paste composition of claim 1 wherein the electrically conductive particles are flake Ag, powdered Ag or mixtures thereof.

7. The paste composition of Claim 1 wherein the glass composition consists essentially of by weight 68-75% Bi₂O₃, 5-15% SiO₂, 5-9% B₂O₃, 0.8-5% Al₂O₃, 0.3-3% CaO, 9-15% ZnO.

8. The paste composition of claim 3 wherein the log (eta) specific viscosity is in a range from 2 at 500C to 4 at 680C for a single glass or volumetrically computed average log (eta) for the glasses.

9. The paste composition of claim 5 wherein the sintering inhibitor is rhodium resinate.

10. An article comprising a rigid substrate with a coating of an electrically conductive patterned layer bonded to the rigid substrate wherein the rigid substrate comprises an optically transparent material and the electrically conductive patterned layer comprises

(a) a lead-free glass composition having a softening point log (eta) - 7.6 poise from 400°C-650°C, a log (eta.) specific viscosity in a range from 2 at 500°C to 5 at 700°C and consisting essentially of, by weight 65-95% Bi₂O₃, 2-15% SiO₂, 0.1-9% B₂O₃, 0-5 % Al₂O₃, 0-5% CaO, and 0-20% ZnO; and

(b) electrically conductive particles.

11. The article of claim 10 wherein an enamel is present within the conductive pattern.

12. The article of claim 10 wherein the rigid substrate is an automobile backlight.

13. The article of Claim 10 wherein the glass composition consists essentially of by weight 68-75% Bi_2O_3 , 5-15% SiO_2 , 5-9% B_2O_3 , 0.8-5% Al_2O_3 , 0.3-3% CaO , and 9-15% ZnO .

5

14. A lead-free glass composition having a softening point $\log (\eta) = 7.6$ poise from 400C-650C, a $\log (\eta)$ specific viscosity in a range from 2 at 500C to 5 at 700C and consisting essentially of, by weight 65-95% Bi_2O_3 , 2-15% SiO_2 , 0.1-9%
10 B_2O_3 , 0-5 % Al_2O_3 , 0-5% CaO , 0-20% ZnO .

15

15. The glass composition of Claim 14 consisting essentially of by weight 68-75% Bi_2O_3 , 5-15% SiO_2 , 5-9% B_2O_3 , 0.8-5% Al_2O_3 , 0.3-3% CaO , 9-15% ZnO .

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INTERNATIONAL SEARCH REPORT

International Application No
PCT/US 94/08070

A. CLASSIFICATION OF SUBJECT MATTER
IPC 6 C03C8/18 C03C3/064 C03C3/066 H01B1/16

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)
IPC 6 C03C

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	DATABASE WPI Section Ch, Week 8128, Derwent Publications Ltd., London, GB; Class L01, AN 81-51374D & SU,A,775 061 (BELORUSSIAN POLY) 31 October 1980 see abstract	14
Y	---	1,2,4,6, 8,10 -/-

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Patent family members are listed in annex.

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Date of the actual completion of the international search

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INTERNATIONAL SEARCH REPORT

International Application No
PCT/US 94/08070

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT

Category	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	DATABASE WPI Section Ch, Week 8309, Derwent Publications Ltd., London, GB; Class L01, AN 83-22132K & SU,A,923 976 (BELORUSS KIROV TECHN INS) 30 April 1982 see abstract	14
Y	---	1,2,4,6, 8,10
X	DATABASE WPI Section Ch, Week 9007, Derwent Publications Ltd., London, GB; Class L01, AN 90-050519 & SU,A,1 477 706 (BELORUSSIAN POLY) 7 May 1989 see abstract	14
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Y	GB,A,2 104 058 (AVX CORPORATION) 2 March 1983 see page 1, line 112 - line 115; claims ----	1,2,4,6, 8,10
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Information on patent family members

International Application No

PCT/US 94/08070

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